

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10537155	LEE ET AL.
Examiner	Art Unit	
O'Reilly III, Patrick F	3749	

SEARCHED

Class	Subclass	Date	Examiner
454	284, 299, 305	12/20/2006	PFO3
62	186	12/20/2006	PFO3
Above	Updated	7/5/2007	PFO3
Above	Updated	2/21/2008	PFO3
239	11, 589.1	2/21/2008	PFO3
Above	Updated	11/24/2008	PFO3
454	237, 261	11/24/2008	PFO3
366	336	11/24/2008	PFO3

SEARCH NOTES

Search Notes	Date	Examiner
EAST (USPAT, USPGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB) searched - printout attached.	12/20/2006; 7/5/2007; 2/21/2008; 11/19/2008; 11/24/2008	PFO3
PLUS search performed - printout of search results attached.	12/20/2006	STIC
Inventor name search performed in PALM and EAST.	12/19/2006; 12/21/2006	PFO3

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
All Classes	Interference search performed - see attached printout.	11/24/2008	PFO3